

<b>Notice of References Cited</b>	Application/Control No. 09/895,935	Applicant(s)/Patent Under Reexamination WONG, HEE	
	Examiner William J Deane	Art Unit 2642	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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**FOREIGN PATENT DOCUMENTS**

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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	U.S. Patent Application No. 2004 (Sindhushayana et al.), 05-2004
	V	U.S. Patent Application No. 2001/0024450 (Takato et al.), 09-2001
	W	U.S. Patent Application no. 2001/0015995 (Emery et al.), 08-2001
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
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